

Notice of References Cited	Application/Control No. 10/025,480		Applicant(s)/Patent Under Reexamination TERAZAWA ET AL.	
	Examiner Laura S Weiner		Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0028368	03-2002	Saito et al.	429/34
*	B	US-6,242,124	06-2001	Saito et al.	429/38
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 2000-331690	11-2000	Japan	Inada et al.	
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	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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